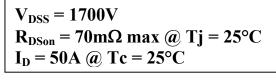
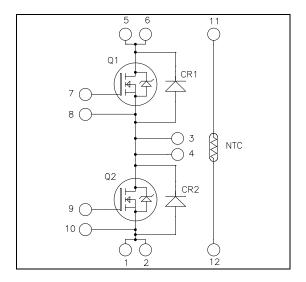
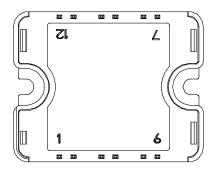


## Phase leg SiC MOSFET Power Module







Pins 1/2; 3/4; 5/6 must be shorted together

### **Application**

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- SiC Power MOSFET
  - High speed switching
  - Low R<sub>DS(on)</sub>
  - Ultra low loss

#### • SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

### All ratings @ $T_i = 25$ °C unless otherwise specified

#### Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Voltage		1700	V
Ţ	Continuous Drain Current	$T_c = 25^{\circ}C$	50	
$I_{\mathrm{D}}$	Continuous Diani Current	$T_c = 80$ °C	37	Α
$I_{DM}$	Pulsed Drain current		100	
$V_{GS}$	Gate - Source Voltage		-10/25	V
$V_{GSOP}$	Gate - Source Voltage ; recommended operation values		-5/20	V
$R_{DSon}$	Drain - Source ON Resistance		70	mΩ
$P_{D}$	Power Dissipation	$T_c = 25^{\circ}C$	350	W

These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

## **Electrical Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 170$			100	μA	
D	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		45	70	
$R_{DS(on)}$		$I_D = 50A$	$T_{j} = 150^{\circ}C$		90		mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 18mA$		2	2.4	4	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				600	nA

## **Dynamic Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$			3672		
$C_{oss}$	Output Capacitance	$V_{DS} = 1000V$			171		pF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz			7		
$Q_{g}$	Total gate Charge	$V_{GS} = -5/+20V$			190		
$Q_{\mathrm{gs}}$	Gate – Source Charge	$V_{Bus} = 900V$	~~		37		nC
$Q_{gd}$	Gate – Drain Charge	$I_D = 50A$			70		
$T_{d(on)}$	Turn-on Delay Time	$- V_{GS} = -5/+20V V_{Bus} = 900V$			105		
$T_{\rm r}$	Rise Time				75		ns
$T_{d(off)}$	Turn-off Delay Time	$I_D = 50A$	$I_D=50A$		210		
$T_{\mathrm{f}}$	Fall Time	$R_{Gext} = 20\Omega$			55		L l
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 900V$	$T_{j} = 150^{\circ}C$		2.2		mJ
$E_{\text{off}}$	Turn off Energy	$I_{D} = 50A$ $R_{Gext} = 20\Omega$	$T_j = 150$ °C		1.5		Ш
$R_{Gint}$	Internal gate resistance				1.3		Ω
$R_{\text{thJC}}$	Junction to Case Thermal Resistan	ce				0.36	°C/W

## **Body diode ratings and characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$ m V_{SD}$	Diada Famyand Valtaga	$V_{GS} = -5V$	$T_j = 25$ °C		4.1		V
	Diode Forward Voltage	$I_{SD} = 25A$	$T_j = 150$ °C		3.6		v
t <sub>rr</sub>	Reverse Recovery Time	$\begin{split} I_{SD} &= 50 A \; ; \; V_{GS} = \text{-}5V \\ V_{R} &= 900 V \; ; \; di_{F}/dt = 1400 A/\mu s \end{split} \label{eq:eq:loss}  . \end{split}$			70		ns
$Q_{rr}$	Reverse Recovery Charge				530		nC
$I_{rr}$	Reverse Recovery Current				14		A



# SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions			Тур	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					1700	V
T	Daviana I salvana Cumment	$V_{R}=1700V$	$T_j = 25$ °C	20		100	^
$I_{RRM}$	Reverse Leakage Current	V <sub>R</sub> -1700 V	$T_{j} = 175^{\circ}C$		100	400	μA
$I_F$	DC Forward Current		Tc = 125°C		25		A
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 25A$	$T_i = 25^{\circ}C$		1.8	2	V
<b>v</b> F		$I_F = 23A$	$T_i = 175^{\circ}C$		3.2	4	·
Qc	Total Capacitive Charge	$I_F = 25A, V_R = 1$ di/dt =400A/ $\mu$ s		170		nC	
С	Total Capacitance	$f = 1 MHz, V_R = 200 V$			200		pF
	Total Capacitance	$f = 1 MHz, V_R =$		140		þr.	
$R_{thJC}$	Junction to Case Thermal Resistance	Case Thermal Resistance				0.48	°C/W

### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

$S_{\mathcal{I}}$	ymbol	Characteristic		Min	Typ	Max	Unit
	R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta$	$R_{25}/R_{25}$				5		%
	B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$			3952		K
4	ΔΒ/Β		T <sub>C</sub> =100°C		4		%

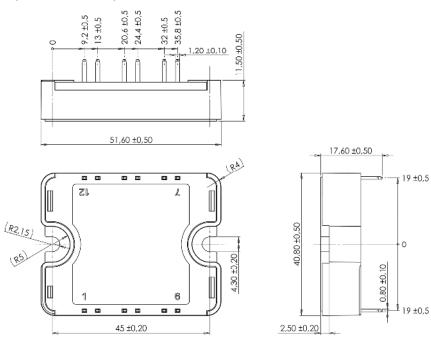
$$R_{T} = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$
 
$$R_{T}: \text{ Thermistor value at T}$$

#### Thermal and package characteristics

Symbol	Characteristic		Min	Max	Unit		
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz						V
Т	Operating junction temperature range	Si	SiC MOSFET -40		MOSFET -40 1		
$T_{J}$	Operating junction temperature range		SiC diode		-40	175	
$T_{JOP}$	Recommended junction temperature under switching conditions				-40	T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range				-40	125	
$T_{\rm C}$	Operating Case Temperature					125	
Torque	Mounting torque	To heatsink M4		2	3	N.m	
Wt	Package Weight		·			80	g

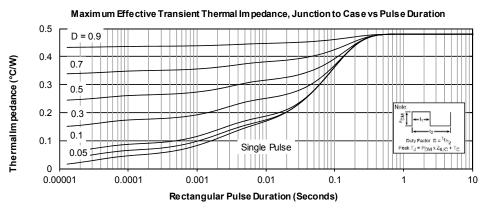


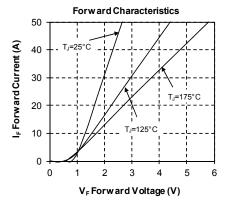
### Package outline (dimensions in mm)

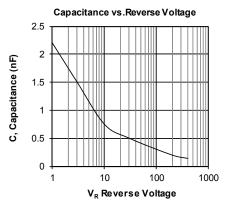


See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

### Typical SiC diode Performance Curve

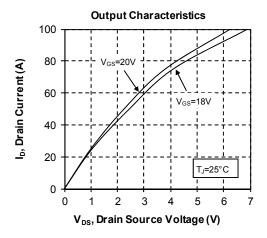


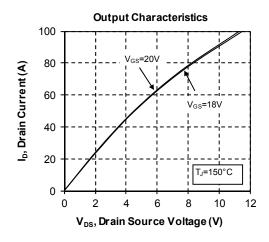


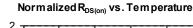


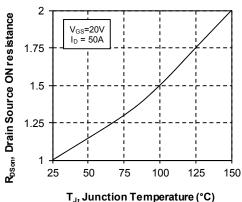


### **Typical SiC MOSFET Performance Curve**

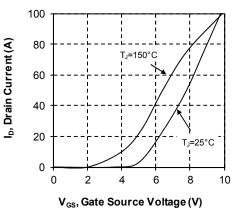




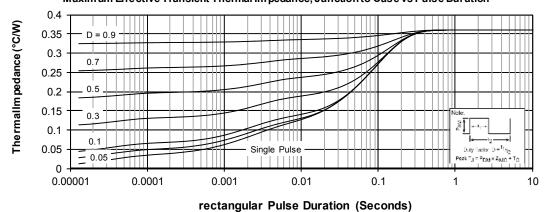




Transfert Characteristics

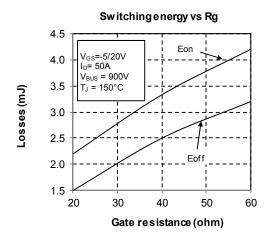


Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



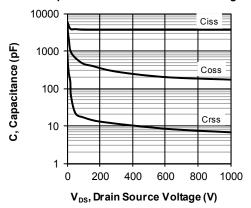


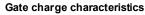
### Power Matters."



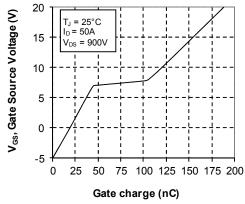
#### Switching energy vs current 2.5 $V_{GS}$ =-5/20V $R_G$ =20 $\Omega$ Eon 2.0 V<sub>BUS</sub>= 900V T<sub>J</sub> = 150°C Losses (mJ) 1.5 1.0 Eoff 0.5 0.0 10 20 30 40 50

#### Capacitance vs Drain to Source Voltage

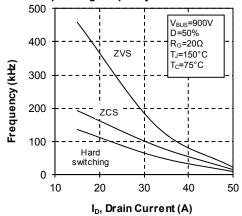




Current (A)



#### Operating Frequency vs Drain Current



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